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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Krahmer et al.

Art Unit : 2872

Serial No. : 10/817,527

Examiner : John Juba, Jr.

Filed : April 1, 2004

Title : OBJECTIVE WITH FLUORIDE CRYSTAL LENSES

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Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

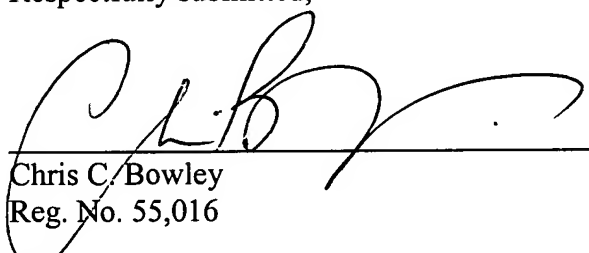
INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed.

This statement is being filed after a Request for Continued Examination but before a subsequent Office Action.

Respectfully submitted,

Date: 2-21-2006


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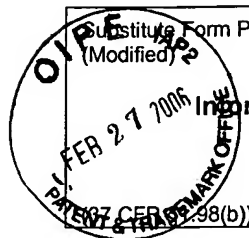
CERTIFICATE OF MAILING BY FIRST CLASS MAIL

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

2/21/06
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Alisa Hocking
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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 17979-006002	Application No. 10/817,527
Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Krahmer et al.	
		Filing Date April 1, 2004	Group Art Unit 2872

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	US 4993823	02/19/91	Schaffer, W., Jr. et al.			

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AB	WO 03/038479	05/08/03	WIPO				
	AC	WO 03/046634	06/05/03	WIPO				
	AD	WO 04/019077	03/04/04	WIPO				
	AE	EP 1139138	10/04/01	Europe				
	AF	EP 1063684	12/27/00	Europe				
	AG	JP 11054411	09/29/97	Japan				
	AH	DE 19637563	03/19/98	Germany				
	AI	DE 19535392	03/27/97	Germany				
	AJ	EP 1115030	07/11/01	Europe				
	AK	EP 0678768	10/25/95	Europe				
	AL	EP 1014139	06/28/00	Europe				
	AM	EP 0952490	10/27/99	Europe				
	AN	EP 0961149	12/01/99	Europe				
	AO	WO/0031592	06/02/00	WIPO				
	AP	EP 0480616	04/15/92	Europe				

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	